

General Description

The WSD4076GDN56 is the highest performance trench N-Ch MOSFET with extreme high cell density, which provide excellent RDSON and gate charge for most of the synchronous buck converter applications. The WSD4076GDN56 meet the RoHS and Green Product requirement, 100% EAS guaranteed with full function reliability approved.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% EAS Guaranteed
- Green Device Available

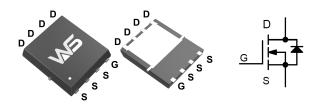
Product Summery

BVDSS	RDSON	ID		
40V	6.9mΩ	76A		

Applications

- High Frequency Point-of-Load Synchronous Buck Converter
- Networking DC-DC Power System
- Power Tool Application

DFN5X6-8L Pin Configuration



Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	40	V
V_{GS}	Gate-Source Voltage	±20	V
I _D @T _C =25℃	Continuous Drain Current, V _{GS} @ 10V	76	Α
I _D @T _C =100°C	Continuous Drain Current, V _{GS} @ 10V	33	А
I _{DM}	Pulsed Drain Current ^a	125	А
EAS	Single Pulse Avalanche Energy ^b	31	mJ
I _{AS}	Avalanche Current 31		Α
P _D @T _a =25℃	Total Power Dissipation	1.7	W
T _{STG}	Storage Temperature Range -55 to 150		$^{\circ}$
T_J	Operating Junction Temperature Range -55 to 1		$^{\circ}$

Thermal Data

Symbol	Parameter	Тур.	Max.	Unit
$R_{ heta JA}$	Thermal Resistance Junction-Ambient ¹		85	°C/W
$R_{ heta JC}$	Thermal Resistance Junction-Case ¹		30	°C/W

Note a: Package is limited.

Note b: UIS tested and pulse width limited by maximum junction temperature 150°C (initial temperature Tj=25°C).



Electrical Characteristics (T_J=25 C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	40			V
$\triangle BV_{DSS}/\triangle T_{J}$	BV _{DSS} Temperature Coefficient	Reference to 25℃, I _D =1mA		0.043		V/℃
R _{DS(ON)}	Static Drain-Source On-Resistance ²	V _{GS} =10V , I _D =12A		6.9	8.5	mΩ
R _{DS(ON)}	Static Drain-Source On-Resistance ²	V _{GS} =4.5V , I _D =10A		10	15	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	-V _{GS} =V _{DS} , I _D =250uA	1.5	1.6	2.5	V
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	VGS-VDS, ID -230UA		-6.94		mV/℃
I _{DSS}	Drain-Source Leakage Current	V_{DS} =32V , V_{GS} =0V , T_J =25 $^{\circ}$ C			2	uA
DSS		V_{DS} =32V , V_{GS} =0V , T_J =55 $^{\circ}$ C			10	uA
I _{GSS}	Gate-Source Leakage Current	V_{GS} = $\pm 20V$, V_{DS} = $0V$			±100	nA
gfs	Forward Transconductance	V _{DS} =5V , I _D =20A		18		S
R_g	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		1.7		Ω
Qg	Total Gate Charge (10V)	V _{DS} =20V , V _{GS} =4.5V , I _D =12A		5.8		
Q _{gs}	Gate-Source Charge			3.0		nC
Q_{gd}	Gate-Drain Charge			1.2		
T _{d(on)}	Turn-On Delay Time	V_{DD} =15V , V_{GEN} =10V , R_{G} =3.3 Ω , I_{D} =1A .		12		
T _r	Rise Time			5.6		no
T _{d(off)}	Turn-Off Delay Time			20		ns
T _f	Fall Time			11		
C _{iss}	Input Capacitance	V _{DS} =15V , V _{GS} =0V , f=1MHz		680		
C _{oss}	Output Capacitance			185		pF
C _{rss}	Reverse Transfer Capacitance			38		

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current ^{1,6}	V _G =V _D =0V , Force Current			76	Α
I _{SM}	Pulsed Source Current ^{2,6}	VG-VD-UV , Force Current			125	Α
V_{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =1A , T _J =25℃			1.2	V

- 1. The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper,t<10sec .
- 2. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2% 3. The EAS data shows Max. rating . The test condition is V_{DD}=20V,V_{GS}=10V,L=0.1mH,I_{AS}=31A 4. The power dissipation is limited by 150°C junction temperature 5. The Min. value is 100% EAS tested guarantee.

- 6.The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.
- 7. Package limitation current is 60A.



Typical Characteristics

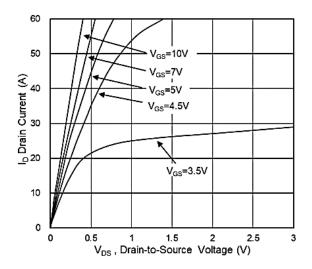


Fig.1 Typical Output Characteristics

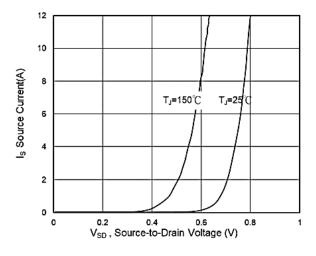


Fig.3 Source Drain Forward Characteristics

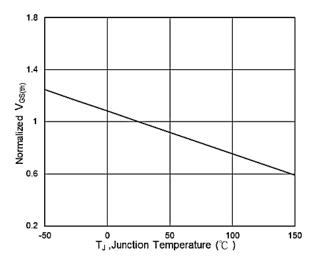


Fig.5 Normalized $V_{\text{GS(th)}}$ vs T_{J}

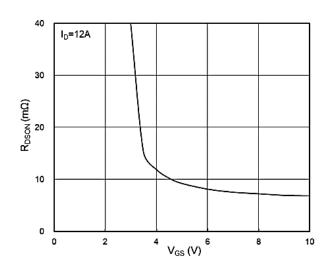


Fig.2 On-Resistance vs G-S Voltage

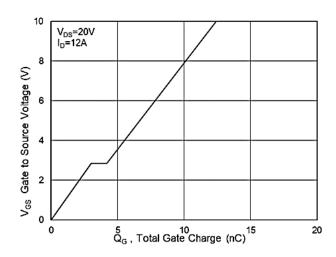


Fig.4 Gate-Charge Characteristics

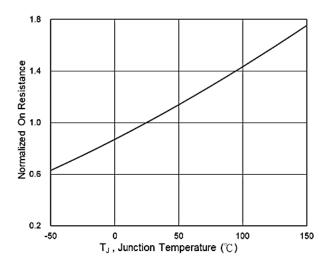


Fig.6 Normalized RDSON vs TJ



Typical Characteristics

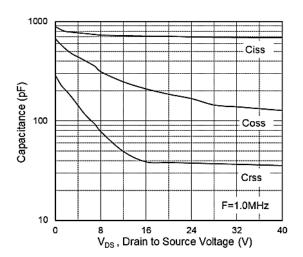


Fig.7 Capacitance

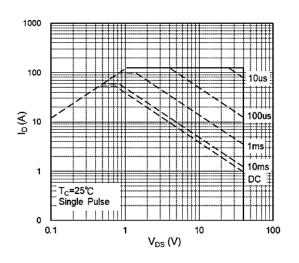


Fig.8 Safe Operating Area

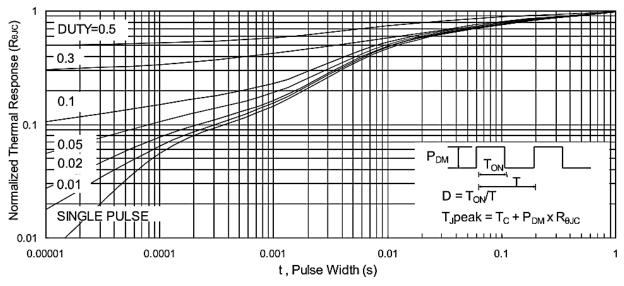


Fig.9 Normalized Maximum Transient Thermal Impedance

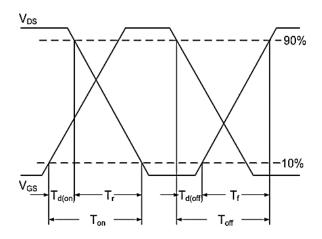


Fig.10 Switching Time Waveform

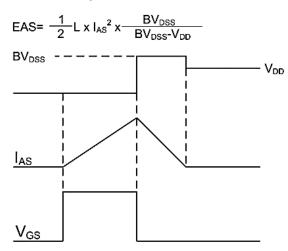


Fig.11 Unclamped Inductive Waveform



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